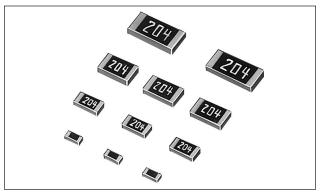
Thick Film Chip Resistors

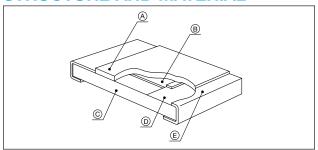
CR, CJ Series



millimeters (inches)



STRUCTURE AND MATERIAL



Code	Structure	Material
Α	Coating	Glass or Epoxy
В	Resistor	RuO ₂ Resistor (The same material of Termination for chip jumper)
С	Substrate	96% Alumina
D	Termination	Silver
E	Plating	(Ni, Sn-Pb) Plating

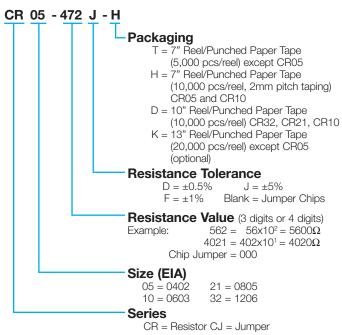
FEATURES

- Low Noise
- Nickel Barrier Terminations

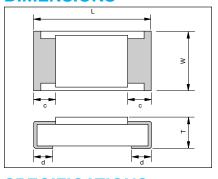
APPLICATION

General Purpose

HOW TO ORDER



DIMENSIONS



	CR05, CJ05 (0402)	CR10, CJ10 (0603)	CR21, CJ21 (0805)	CR32, CJ32 (1206)
w	0.50±0.05	0.80 ^{+0.15} _{-0.10}	1.25 ⁺ 0:15	1.55 ⁺ 8:15
	(0.020±0.002)	(0.031 ^{+0.006} _{-0.004})	(0.050 ⁺ 0:006)	(0.061 ⁺ 8:884)
L	1.00±0.05	1.60±0.10	2.00±0.10	3.10±0.10
	(0.039±0.002)	(0.063±0.004)	(0.080±0.004)	(0.122±0.004)
С	0.20±0.15	0.25±0.20	0.35±0.20	0.45±0.20
	(0.008±0.006)	(0.010±0.008)	(0.014±0.008)	(0.018±0.008)
d	0.20±0.10	0.20 ±0.20	0.40±0.20	0.45±0.20
	(0.008±0.004)	(0.008 ±0.008)	(0.016±0.008)	(0.018±0.008)
Т	0.35±0.05	0.50±0.10	0.55±0.10	0.55 ^{+0.10}
	(0.014±0.002)	(0.020±0.004)	(0.022±0.004)	(0.022 ^{+0.004})

SPECIFICATIONS

Series	CR05 (0402)	CR10 (0603)	CR21 (0805)	CR32 (1206)
Rated Power	0.0625 (1/16) W	0.10 (1/10) W	0.125 (1/8) W	0.25 (1/4) W
Max. Working Voltage	50V	50V	100V	200V
Resistance Tolerance	F = ±1% J = ±5%	$D = \pm 0.5\%$ $F = \pm 1\%$ $J = \pm 5\%$	$D = \pm 0.5\%$ $F = \pm 1\%$ $J = \pm 5\%$	$D = \pm 0.5\%$ $F = \pm 1\%$ $J = \pm 5\%$
Resistance Value Range	10 Ω to 1M Ω : F 1.0 Ω to 10M Ω : J	10Ω to $1M\Omega$: D 10Ω to $1M\Omega$: F 1.0Ω to $10M\Omega$: J	10Ω to $1M\Omega$: D 10Ω to $1M\Omega$: F 1.0Ω to $10M\Omega$: J	10Ω to $1M\Omega$: D 10Ω to $1M\Omega$: F 1.0Ω to $10M\Omega$: J
Working Temperature	-55 to +125°C	-55 to +125°C	-55 to +125°C	-55 to +125°C



Thick Film Chip Resistors

CR, CJ Series



millimeters (inches)

SPECIFICATIONS

CJ Series

Part Number	CJ05, CJ10, CJ21 (0402, 0603, 0805 Type)	CJ32 (1206 Type)
Rated Current	1A (70°C)	2A (70°C)
Resistivity	50m $Ω$ max.	50m $Ω$ max.
Working Temperature	-55 to +125°C	-55 to +125°C

HOW TO CALCULATE RATED VOLTAGE

 $E = \sqrt{P \cdot R}$

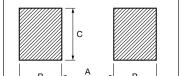
E = Rated Voltage (V)

P = Rated Power (W)

 $R = Standard Resistance Value (\Omega)$

Rated voltage should be lower than max. working voltage.

RECOMMENDED LAND PATTERN



EIA Size	0402	0603	0805	1206
Α	0.50	0.80	1.00	2.00
	(0.020)	(0.031)	(0.039)	(0.079)
В	0.40	0.70	0.80	0.80
	(0.016)	(0.028)	(0.031)	(0.031)
С	0.50	0.80	1.20	1.50
	(0.020)	(0.031)	(0.047)	(0.059)

MARKING

Marking available as follows:

Series: CR32, CJ32, CR21, CJ21, CR10, CJ10

3 digit indication

Example: $473=47 \times 10^3 = 47000 \ \Omega = 47 \ k\Omega$

 $0 = 0 \Omega$ (Jumper)

 $100 = 10 \ \Omega$

 $102=1~k\Omega$

 $105 = 1 M\Omega$



Series: CR05 and CJ05 - No marking

Note: On CR32 4 digit marking is standard for ±1% and ±0.5% tolerances.

STANDARD RESISTANCE VALUE

E24	2.4	2.7	3.0	3.3	3.6	1.6 3.9	 	
	5.6	6.2	6.8	7.5	8.2	9.1		

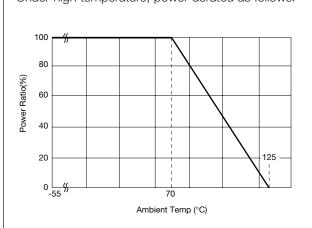
For ±1% and ±.5% Tolerance

			, -							
	10.0	10.2	10.5	10.7	11.0	11.3	11.5	11.8	12.1	12.4
	12.7	13.0	13.3	13.7	14.0	14.3	14.7	15.0	15.4	15.8
	16.2	16.5	16.9	17.4	17.8	18.2	18.7	19.1	19.6	20.0
	20.5	21.0	21.5	22.1	22.6	23.2	23.7	24.3	24.9	25.5
E96	26.1	26.7	27.4	28.0	28.7	29.4	30.1	30.9	31.6	32.4
	33.2	34.0	34.8	35.7	36.5	37.4	38.3	39.2	40.2	41.2
	42.2	43.2	44.2	45.3	46.4	47.5	48.7	49.9	51.1	52.3
	53.6	54.9	56.2	57.6	59.0	60.4	61.9	63.4	64.9	66.5
	68.1	69.8	71.5	73.2	75.0	76.8	78.7	80.6	82.5	84.5
	86.6	88.7	90.9	93.1	95.3	97.6				

DERATING CURVE

Rated power should be reduced as below when temperature become higher.

Under high temperature, power derated as follows:



Chip Resistor Arrays



CR, CJ, CRA, CRB, CRC Series - Test Conditions

ELECTRICAL CHARACTERISTICS

Item		Standard		Test Conditions		
		Resistor	Jumper	Resistor	Jumper	
DC Resist	tance	Within Initial Tolerance	50m $Ω$ max.	Power Condition (20°C, 65% F		
Temperature Characteristics		$ \begin{array}{c cccc} \textbf{Resistance (Ω)} & \textbf{TCR (ppm/°C)} \\ \hline D, F \\ 10 \le R \le 1M & -100 \text{ to } +100 \\ \hline J & \\ R < 10 & -100 \text{ to } +600 \\ 10 \le R \le 1M & -200 \text{ to } +200 \\ 1M < R & -500 \text{ to } +300 \\ \hline \end{array} $		Test Temperature: 25, 125(°C) Δ R/R=R ₂ -R ₁ /R ₁ x1/T ₂ -T ₁ x10 ⁶ Δ R/R = Temp. Coefficient (ppm/°C) T ₁ = 25(°C) T ₂ = 125(°C) R ₁ = T ₁ Resistance at (Ω) R ₂ = T ₂ Resistance at (Ω)		
Short-time Overload	ΔR/R	$\pm (2.0\% + 0.10\Omega)$ max. of the initial value	50m $Ω$ max.	 (1) Apply 2.0 x rated voltage for 5 sec. (2.5 x rated voltage for Arrays) (2) Wait 30 minutes (3) Measure resistance CR05 = 50V max. CR10 = 100V max. CR21 = 200V max. CR32 = 400V max. CRA, CRB, CRC = 100V max. 	(1) 2A for 5 sec. (2) Wait 30 minutes (3) Measure resistance	
	Visual	No evidence of mechanical d intermittent overload	amage			
Intermittent Overload	ΔR/R	$\pm (5\% + 0.1 \Omega)$ max. of the initial value	50m $Ω$ max.	(1) Perform 10,000 voltage cycles as follows: ON (2.0 x rated voltage, 2.5 x for Arrays) 1 sec. OFF 25 sec. (2) Stabilization time 30 min. without loading (3) Measure resistance CR05 = 50V max. CR10 = 150V max.	(1) Perform 10,000 current cycles as follows: ON (2A) 1 sec. OFF 25 sec. (2) Wait 30 minutes (3) Measure resistance	
	Visual	No evidence of mechanical d	lamage	CR21 = 200V max. CR32 = 400V max. CRA, CRB, CRC = 100V max.		
Dielectr Withstanding		No evidence of mechanical d	amage	Apply 500 VAC for 1 min. (CR10 (CR05, CRA, CRB, CRC 300		
Insulation Resistance		• CR05, CJ05 = $10^{8}\Omega$ min. • CR10, CJ10 = $10^{9}\Omega$ min. • CR21, CJ21 = $10^{10}\Omega$ min. • CR32, CJ32 = $10^{12}\Omega$ min. • CRA, CRB, CRC = $10^{9}\Omega$ min.		Apply 500V DC (CR05, CRA, CRB, CRC 100V D	C)	



Chip Resistor Arrays



CR, CJ, CRA, CRB, CRC Series - Test Conditions

MECHANICAL CHARACTERISTICS

Item		Standard	Test Conditions				
Item		Resistor	Jumper	Resistor	Jumper		
	Δ R/R	$\pm (1\% + 0.05\Omega)$ max. of the initial value	50mΩ max.	Apply the load as shown: Measure resistance during load application			
Terminal Strength	Visual	No evidence of mechanical damage afte	er loading	Bending in 10 seconds PC Board = Glass epoxy t = 1.60	45 (1.772) 45 (1.772)		
Soldering Heat	ΔR/R	$\pm (1\% + 0.05\Omega)$ max. of the initial value	Stabilize component at room tempe				
Resistance	Visual	No evidence of leaching		Measure resistance.			
Solderabi	lity	Coverage ≥95% each termination	end	Immerse in Rogin Flux for 2±0.5 SN62 solder at 235±5°C for 2±0			
Anti-Vibration	ΔR/R	\pm (1%+0.1 Ω) max. of the initial value	50mΩ max.	2 hrs. each in X, Y and Z axis. (TTL 6 hrs.) 1 sweep in 1 min. at 1.5mm amplitude.			
Test	Visual	No evidence of mechanical damag	ре				
Solvent Resistance	ΔR/R	$\pm (0.5\% + 0.05\Omega)$ max. of the initial value	50m $Ω$ max.	Immerse in static state butyl acetate at 20°C to 2 for 30±5 sec. Stabilize component at room temperature for 30			
	Visual	No evidence of mechanical damag	ge	then measure value.			

ENVIRONMENTAL CHARACTERISTICS

ENVIRON	IVIENTA	L CHARACTERISTICS				
Item		Standard	Test Condit	tions		
Item		Resistor	Jumper	Resistor	Jumper	
Temperature	Δ R/R	$\pm (1\% + 0.05\Omega)$ max. of the initial value	50mΩ max.	(1) Run 5 cycles as follows: -55±: 125±3°C for 30 min. Room to	emp. for 10-15 min.	
Cycle	Visual	No evidence of mechanical damaç	je	(2) Stabilize component at room then measure value.	temperature for 1 hr.	
Low Temperature	ΔR/R	$\pm (2\% + 0.1\Omega)$ max. of the initial value	50mΩ max.	(1) Dwell in -55°C chamber withouthrs.		
Storage	Visual	No evidence of mechanical dama	ge	(2) Stabilize component at room then measure value.	temperature for 1 hr.	
High Temperature	Δ R/R	$\pm (3\% + 0.1\Omega)$ max. of the initial value	50mΩ max.	(1) Dwell in 125°C chamber witho hrs.	ut loading for 1000 ⁺⁴⁸ ₋₀	
Storage	Visual	No evidence of mechanical dama	ge	(2) Stabilize component at room temperature for 1 then measure value.		
Moisture	ΔR/R	$\pm (3\% + 0.1\Omega)$ max. of the initial value	50m $Ω$ max.	(1) Dwell in temp.: 65°C RH90 to without loading for 1000 +48 hr	rs.	
Resistance	Visual	No evidence of mechanical dama	ge	(2) Stabilize component at room then measure value.	temperature for 1 hr.	
Life Test	ΔR/R	$\pm (3\% + 0.1\Omega)$ max. of the initial value	50m $Ω$ max.	(1) Temp.: 70±3°C Voltage: (rate off 30 min. Duration: 1000 ⁺⁴⁸	hrs.	
	Visual	No evidence of mechanical dama	o evidence of mechanical damage		temperature for 1 hr.	
Loading Life	ΔR/R	$\pm (3\% + 0.1\Omega)$ max. of the initial value	50m $Ω$ max.	(1) Temp.: 40±2°C RH: 90-95% min. (rated voltage) off 30 min.	Duration: 1000 +48 hrs.	
in Moisture	Visual	No evidence of mechanical dama	ge	(2) Stabilize component at room temperature for 1 then measure value.		

